

<b>Notice of References Cited</b>	Application/Control No. 10/542,002		Applicant(s)/Patent Under Reexamination TOGANO ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0048521 A1	03-2003	Ikeda et al.	359/296
*	B	US-2006/0087489 A1	04-2006	Sakurai et al.	345/107
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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#### FOREIGN PATENT DOCUMENTS

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	N					
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#### NON-PATENT DOCUMENTS

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